### **RF Inductor**



#### **BWCM Series**



#### Overview

Wire-wound RF inductors are electronic components designed to store energy in a magnetic field when electrical current passes through them. They are constructed by winding a conductive wire (usually copper or gold-plated) around a core material such as air, ceramic, or ferrite.

This configuration allows them to provide high inductance values with minimal power loss, especially at high frequencies.

#### **Benefits**

- 1. High Q-Factor (Quality Factor)
- 2. Ceramic body and wire wound construction provide high SRFs
- 3. Low DC resistance design
- 4. High Current Handling
- 5. Can maintain excellent thermal stability at different temperatures

#### **Applications**

- 1. Industrial and Medical Equipmen: RFID systems and medical imaging equipment.
- 2. Data Centers
- 3. Networking
- 4. Base Station
- 5. Consumer Electronics
- 6. Security system

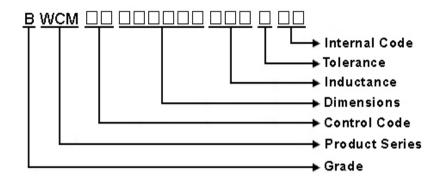
#### **Product Information**

Series	Size Code (JIS/EIA)	Inductance (nH)
BWCM	0603/0201	1 ~ 470
	1005/0402	
	1608/0603	





- 1 Scope: This specification applies to Wire Wound Ceramic Chip Inductors
- 2 Part Numbering:



3 Rating:

Operating Temperature:  $-40^{\circ}$ C  $\sim 125^{\circ}$ C

(Including self - temperature rise)

Storage Temperature:  $-40^{\circ}$ C  $\sim 125^{\circ}$ C

(The storage temperature range is for after the assembly)

4 Marking:

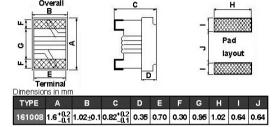
No Marking

### 5 Standard Testing Condition

Unless otherwise specified		In case of doubt
Temperature	Ordinary Temperature(15 to 35℃)	20 to 30℃
Humidity	Ordinary Humidity(25 to 85% RH)	50 to 80 %RH



## 6 Configuration and Dimensions and Unit Weight:



### 7 Electrical Characteristics:

Part No.	Inductance (nH)	L/Q Test Freq. (MHz)	Q Min.	SRF (MHz)Min.	RDC (Ω)Max.	Irms (mA)Max.	Tolerance
BWCM001610082N2□00	2.2	100/250	16	6000	0.049	700	B,C,D
BWCM001610083N6□00	3.6	100/250	25	6000	0.059	850	H,J,G
BWCM001610083N9□00	3.9	100/250	35	6000	0.059	850	H,J
BWCM001610084N3□00	4.3	100/250	35	6000	0.059	850	H,J
BWCM001610084N7□00	4.7	100/250	35	6000	0.059	850	H,J,D
BWCM001610085N6□00	5.6	100/250	35	6000	0.082	750	H,J,C
BWCM001610086N2□00	6.2	100/250	35	6000	0.082	750	H,J
BWCM001610086N8□00	6.8	100/250	35	6000	0.082	750	H,J
BWCM001610087N5□00	7.5	100/250	35	6000	0.082	750	H,J
BWCM001610088N2□00	8.2	100/250	35	6000	0.11	650	H,J
BWCM001610088N7□00	8.7	100/250	35	6000	0.11	650	H,J
BWCM001610089N1□00	9.1	100/250	35	6000	0.11	650	C,H,J
BWCM001610089N5□00	9.5	100/250	35	6000	0.11	650	G,H,J
BWCM0016100810N□00	10	100/250	35	6000	0.11	650	G,J
BWCM0016100811N□00	11	100/250	35	6000	0.11	650	G,J
BWCM0016100812N000	12	100/250	35	6000	0.13	600	G,J
BWCM0016100813N□00	13	100/250	35	6000	0.13	600	G,J
BWCM0016100815N000	15	100/250	40	6000	0.13	600	G,J
BWCM0016100816N□00	16	100/250	40	5500	0.16	550	G,J
BWCM0016100818N□00	18	100/250	40	5500	0.16	550	G,J
BWCM0016100820N□00	20	100/250	40	4900	0.16	550	G,J
BWCM0016100822N□00	22	100/250	40	4600	0.17	500	G,J
BWCM0016100824N□00	24	100/250	40	3800	0.21	500	G,J
BWCM0016100827N□00	27	100/250	40	3700	0.21	440	G,J
BWCM0016100830N□00	30	100/250	40	3300	0.23	420	G,J

NOTE: □-tolerance B=±0.1nH / C=±0.2nH / D=±0.5nH / H=±3%/ J=±5% / G=±2%

<sup>1.</sup> Operating temperature range  $-40 \,^{\circ}\text{C} \sim 125 \,^{\circ}\text{C}$  (Including self - temperature rise)

<sup>2.</sup>Irms for a 15°C temperature rise from 25°C ambient.

<sup>3.</sup>L/Q Test OSC @200mV.

<sup>4.</sup>Inductance would be correct Chilisin standard piece.

<sup>5.</sup>offset value -0.771n H



Part No.	Inductance (nH)	L/Q Test Freq. (MHz)	Q Min.	SRF (MHz)Min.	RDC (Ω)Max.	Irms (mA)Max.	Tolerance
BWCM0016100833N□00	33	100/250	40	3200	0.23	420	G,J
BWCM0016100836Na00	36	100/250	40	2900	0.26	400	G,J
BWCM0016100839N□00	39	100/250	40	2800	0.26	400	G,J
BWCM0016100843N□00	43	100/200	40	2700	0.29	380	G,J
BWCM0016100847N□00	47	100/200	38	2600	0.29	380	G,J
BWCM0016100851N□00	51	100/200	38	2500	0.33	370	G,J
BWCM0016100856N□00	56	100/200	38	2400	0.35	360	G,J
BWCM0016100862N□00	62	100/200	38	2300	0.51	280	G,J
BWCM0016100868N□00	68	100/200	38	2200	0.38	340	G,J
BWCM0016100872N□00	72	100/150	34	2100	0.56	270	G,J
BWCM0016100875N□00	75	100/150	34	2050	0.56	270	G,J
BWCM0016100882N□00	82	100/150	34	2000	0.6	250	G,J
BWCM0016100891N□00	91	100/150	34	1900	0.64	230	G,J
BWCM00161008R10□00	100	100/150	34	1800	0.68	220	G,J
BWCM00161008R11□00	110	100/150	32	1700	1.2	200	G,J
BWCM00161008R12□00	120	100/150	32	1600	1.3	180	G,J
BWCM00161008R13□00	130	100/150	32	1450	1.4	170	G,J
BWCM00161008R15□00	150	100/150	32	1400	1.5	160	G,J
BWCM00161008R16□00	160	100/150	32	1350	2.1	150	G,J
BWCM00161008R18□00	180	100/100	25	1300	2.2	140	G,J
BWCM00161008R20□00	200	100/100	25	1250	2.4	120	G,J
BWCM00161008R22 = 00	220	100/100	25	1200	2.5	120	G,J
BWCM00161008R27□00	270	100/100	30	960	3.4	110	G,J
BWCM00161008R33□00	330	100/100	30	800	5.5	85	G,J
BWCM00161008R39□00	390	100/100	30	800	6.2	80	G,J
BWCM00161008R47□00	470	100/100	30	700	7	75	G,J

NOTE: □-tolerance B=±0.1nH / C=±0.2nH / D=±0.5nH / H=±3%/ J=±5% / G=±2%

<sup>1.</sup> Operating temperature range  $-40\,^{\circ}\text{C} \sim 125\,^{\circ}\text{C}$  (Including self - temperature rise)

<sup>2.</sup>Irms for a 15°C temperature rise from 25°C ambient.

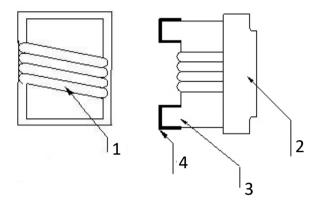
<sup>3.</sup>L/Q Test OSC @200mV.

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<sup>5.</sup>offset value -0.771n H



# 8 BWCM00161008 Series 8.1 Construction:



### 8.2 Material List:

NO	PART	MATERIAL
1	WIRE	COPPER 180
2	EPOXY	UV GLUE
3	CORE	CERAMIC
4	TERMINAL	Ag/Ni/Sn



## 9 Reliability Of Ceramic Wire Wound Chip Inductor/CERAMIC SERIES

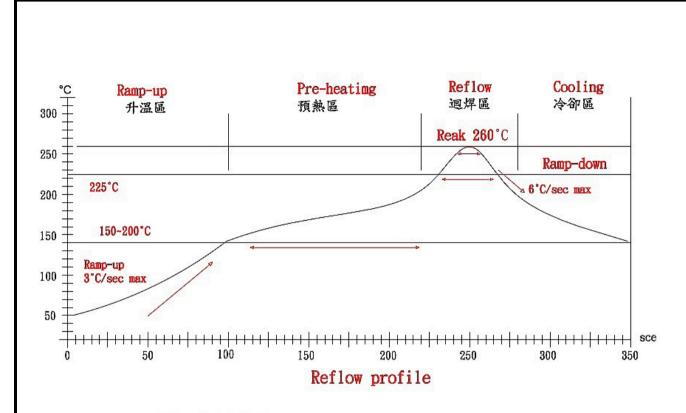
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No	Item	Specification		Test Method	
1-1-1	Temperature Cycle	Appearance: No Damage	One cycle:		
		Inductance:within±10% of	Step	Temperature (°ℂ)	Time (min)
		initial value	1	-40±3	30
		Q change:within±30% of	2	25±2	15
		initial value	3	125±3	30
			4	25±2	15
			Total: 5 cycle	es	
			Measured Af	fter Exposure in The Room Condit	tion For 1hrs
1-1-2	High Temperature Resistance		Temperature	e: 125±3℃	
			Time:1000Hi	rs	
			Measured Af	fter Exposure In The Room Condit	tion For 1Hrs
1-1-3	Low Temperature Resistance		Temperature	e: -40±3℃	
			Time: 1000H	Irs	
			Measured Af	fter Exposure In The Room Condit	tion For 1Hrs
1-1-4	Humidity Load Life	There should be no evidence	Temperature	e: 40±2°ℂ	
		of short or open circle	Relative Hun	nidity: 90~95%	
			Load: Allowe	ed DC Current	
			Time: 96Hrs		

1-2.Mechanical Performance

No	Item	Specification	Test Method
1-2-1	Vibration Test	1.Appearance: No Damage	Test device shall be soldered on the substrate.
	(Low Frequency)	2.Inductance:within±10% of	2. Oscillation frequency: 10 to 55 to 10Hz for 1min.
		initial value	3. Amplitude: 1.5mm
		3.Q change:within±30% of	4. Time: 2hrs for each axis(X, Y & Z),total 6hrs
		initial value	
1-2-2	Resistance TO	Appearance: No Damage	The device should be reflow soldered on PCB
	Soldering Heat		(peak 260°C±5°C for 10 seconds)
			2. Solder Composition: Sn/Ag3.0/Cu0.5
			3. Test time: 6 minutes
1-2-3	Solder ability	The electrodes shall be	1. Pre-Heating: 150℃,1min.
		at least 95% covered	2. Solder Composition: Sn/Ag3.0/Cu0.5
		with new solder coating	3. Solder Temperature: 245±5℃.
			4. Immersion Time: 4±1 sec.
1-2-4	Component	1 Lbs. For 0402	The device should be reflow soldered (245±5°C For
	Adhesion	2 Lbs. For 0603	10 seconds) to a tinned copper substrate. A force gauge
	(Push Test)	4 Lbs. For The Rest	should be applied to the side of the component.
			The device must withstand a minimum force of 2 or 4 pounds
			without a failure of the termination attached to component





#### Lead-Free(LF)標準溫度分析範圍

Refer to J-STD-020C

管制項目 Item.	升溫區 Ramp-up	預熱區 Pre-heating	迴焊區 Reflow	Peak Temp	冷卻區 Cooling
温度範圍 Temp.scope	R.T ~ 150°C	150℃ ~ 200℃	Above 217°C	260±5°C	Peak Temp.~150℃
標準時間 Time spec.	-	60 ~ 180 sec	60 ~ 150 sec	20 ~ 40 sec	-
實際時間 Time result	_	75 ~ 100 sec	90 ~ 120 sec	20 ~ 35 sec	-

#### NOTE:

- 1.Re-flow possible times: within 3 times
- 2. Nitrogen adopted is recommendes while in re-flow
- 3. Products can only be soldered with reflow



### 10 Packaging:

### 10.1 Packaging -Cover Tape

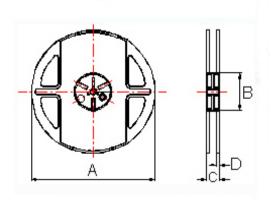
The force for tearing off cover tape is 10 to 100 grams in the arrow direction.



### 10.2 Packaging Quantity

TYPE	PCS/REEL
161008	4000

#### 10.3 Reel Dimensions



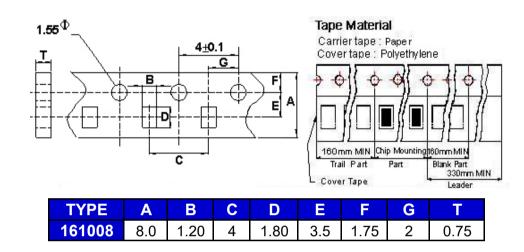
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TYPE			•	D
161008	178±1	60±0.5	12±0.5	1.5±0.5

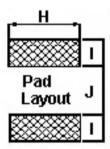


### 10 Packaging:

#### 10.4 Tape Dimensions in mm



### 11 Recommended Land Pattern:



#### Dimensions in mm

TYPE	H(In/mm)	l(ln/mm)	J(In/mm)
161008	0.04/1.02	0.025/0.64	0.025/0.64

### 12 Note:

- 1. Please make sure that your product has been evaluated and confirmed against your specifications when our product is mounted to your product.
- 2. Do not knock nor drop.
- 3. All the items and parameters in this product specification have been prescribed on the premise that our product is used for the purpose,under the condition and in the environment agreed upon between you and us. You are requested not to use our product deviating from such agreement.
- 4.The storage period is less than 12 months. Be sure to follow the storage conditions (Temperature: 5 to 40°C, Humidity: 10 to 75% RHor less).
- If the storage period elapses, the soldering of the terminal electrodes may deteriorate.
- 5.Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).
- 6. The moisture sensitivity level (MSL) of products is classified as level 1.



